## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | MIYAIRI ET AL. | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,975,386	12-2005	Tsumura et al.	356/30
*	В	US-6,647,148	11-2003	Ozawa et al.	382/199
*	С	US-2005/0041226	02-2005	Tanaka et al.	355/053
*	D	US-2003/0142298	07-2003	Ujihara et al.	356/237.2
*	E	US-6,861,614	03-2005	Tanabe et al.	219/121.66
*	F	US-2004/0228526	11-2004	Lin et al.	382/165
*	G	US-5,835,614	11-1998	Aoyama et al.	382/104
*	Н	US-5,091,963	02-1992	Litt et al.	382/149
*	ı	US-6,836,532	12-2004	Durst et al.	378/73
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.